Notice of References Cited

	Application/Control No.	Applicant(s)/Patent Under		
	10/591,390	Reexamination VAN DER WOLF ET AL.		
	Examiner	Art Unit		
	Andrew C. Lee	2419	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,611,624	08-2003	Zhang et al.	382/232
*	В	US-6,477,204	11-2002	Fukushima et al.	375/240.28
*	O	US-7,065,141	06-2006	Okada, Shigeyuki	375/240.25
*	D	US-2006/0153540	07-2006	Itoh et al.	386/112
*	Е	US-6,542,541	04-2003	Luna et al.	375/240.01
*	F	US-6,470,051	10-2002	Campisano et al.	375/240.21
*	G	US-6,871,001	03-2005	Okada, Shigeyuki	386/6
*	Н	US-6,792,047	09-2004	Bixby et al.	375/240.26
*	_	US-5,937,138	08-1999	Fukuda et al.	386/112
*	J	US-6,310,921	10-2001	Yoshioka et al.	375/240.26
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

 NON-PATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	w				
	x				

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